

# APPENDIX

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The references listed here have appeared in the form of books, manuals, brochures, or articles in technical publications. Individual items have been selected because of their general or specific interest, or because of an excellent list of reference sources.

It should be noted, however, that much of the most-advanced, relevant, and useful material available in this rapidly-growing and changing field is that published by manufacturers of products in the course of the ordinary business of trying to sell their products. Such publications as the Analog Devices *Product Guide* and technical data sheets, as well as those of our competitors, may well have the most current and useful information available relating to a given product area.

Certainly, every designer should be sure that his suppliers keep him up to date on new products, applications ideas, and techniques. (Analog Devices uses *Analog Dialogue* as a vehicle to accomplish this objective.) Our readers are invited to request any material of interest mentioned above, that is published by Analog Devices, as well as to subscribe to *Analog Dialogue*.

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